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Plasma-Photocatalyst Interaction for VOC Removal: Origin of the Synergy

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It is well known that the coupling of an atmospheric non-thermal plasma with catalytic materials lead to synergetic effects for the abatement of some volatiles organic compounds (VOC). We analyze, here, the mechanisms of such a synergy where the catalyst is a porous semi-conductor (TiO₂). Different porous materials are compared: silica fibers possibly containing SiO₂ and/or TiO₂ nanoparticles. The respective influence of the porosity versus the chemical type of the catalyst is investigated and the oxidizing species are identified using two complementary approaches. 1) Efficiency of the plasma-catalyst coupling in a dielectric barrier discharge (DBD) at atmospheric pressure, 2) Plasma-catalytic surface interaction in a pulsed low pressure discharge. It is shown that the VOC oxidation scales as a function of the specific injected energy and occurs mainly on the porous surface due to short-life species produced the plasma [1-3]; Time resolved and in-situ measurements using laser absorption spectroscopy and emission spectroscopy in a low-pressure experiment have shown that i) plasma-TiO₂ synergy is also evidenced at low pressure[4], ii) O atoms are reversively adsorbed on porous nanoparticles of TiO₂; their desorption occur during the first millisecond of a plasma pulse [5], iii) air-plasma pre-treatment of the porous material leads to an enhancement of VOC adsorption on porous TiO₂ and has no influence on porous silica.

[1] U. Roland et al. *Catalysis Today* **73** 315–323

[2] F. Thevenet et al. *Catal. Today* 122 (2007) 186–194

[3] F. Thevenet et al. *International Journal of Plasma Environmental Science and Technology*, 1, (2007), 52-56

[4] A. Rousseau et al. *Appl. Phys. Lett.* 87, 221501 (2005)

[5] Allegraud et al. *J. Phys. D. : Appl. Phys* submitted.

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